Another broadly applicable class of tests is the likelihood ratio test (LRT). Let

$$T(X) = \frac{\sup_{\theta \in \Theta} \mathcal{L}_n(\theta)}{\sup_{\theta \in \Theta_0} \mathcal{L}_n(\theta)}$$

If T(X) is large, it means there are values of θ in Θ_1 which are larger than for any in Θ_0 . A likelihood ratio test is a test for which

$$R = \{x : T(x) > c\}$$

If $\hat{\theta}_n$ is the MLE and $\hat{\theta}_{n,0}$ is the MLE restricting $\theta \in \Theta_0$, then

$$T(X) = \frac{\mathcal{L}_n(\hat{\theta}_n)}{\mathcal{L}_n(\hat{\theta}_{n,0})}$$

Sometimes we can calculate the power function for the LRT exactly.

Example: Suppose $X_1, \ldots, X_n \stackrel{iid}{\sim} N(\theta, 1)$. Consider testing $H_0: \theta = \theta_0$ versus $H_1: \theta \neq \theta_0$. Find T(X) and find a simplified expression for the form of the rejection region. Use it to find the size α LRT.

When the power function can not be calculated exactly, and Θ_0 consists of fixing certain elements of θ (e.g., as in a point-null hypothesis), we can use the limiting distribution

$$\lambda(X) = 2 \log T(X) \xrightarrow{D} \chi_{r-q}^2$$

where r is the dimension of θ and q is the number of restricted elements.

Aside: The χ^2_k distribution (read "chi squared with k degrees of freedom") is the distribution of the sum of squares of k independent standard normal random variables. That is, if $Z_1, \ldots, Z_k \stackrel{iid}{\sim} N(0,1)$, then

$$Y = \sum_{i=1}^k Z_i^2 \sim \chi_k^2$$

We can use this approximation to find an appropriate critical value.

Example: Suppose $X_1, \ldots, X_n \stackrel{iid}{\sim} Poisson(\theta)$. Let $\hat{\theta}_n = \sum_{i=1}^n X_i/n$ be the MLE for θ . For testing $H_0: \theta = \theta_0$ versus $H_1: \theta \neq \theta_0$, we have

$$\lambda = 2 \log \frac{\mathcal{L}(\hat{\theta}_n)}{\mathcal{L}(\theta_0)}$$

$$= 2 \log \frac{e^{-n\hat{\theta}_n} \hat{\theta}_n^{\sum x_i}}{e^{-n\theta_0} \theta_0^{\sum x_i}}$$

$$= 2n[(\theta_0 - \hat{\theta}_n) - \hat{\theta}_n \log(\theta_0/\hat{\theta}_n)]$$

Since for large n, $\lambda \stackrel{D}{\approx} \chi_1^2$, to construct an approximate size α LRT, we find $\chi_{1,\alpha}^2$ s.t. $P(\chi_1^2 < \chi_{1,\alpha}^2) = 1 - \alpha$ and reject H_0 if $\lambda > \chi_{\alpha}^2$.

Suppose that for every $\alpha \in (0,1)$ we have a size α test with rejection region R_{α} . Then

$$p
-value = \inf\{\alpha : T(X) \in R_{\alpha}\}\$$

That is, the p-value is the smallest level at which we can reject H_0 .

When
$$R_{\alpha} = \{x : T(x) \ge c_{\alpha}\}$$
,

$$p
-value = \sup_{\theta \in \Theta_0} P_{\theta}(T(X) \ge T(x))$$

where x is the observed data.

Therefore, the p-value is the probability under H_0 of observing a value T(X) the same as or more extreme than what was actually observed.

In the case of the Wald test, the (approximate) p-value is

p-value
$$= P_{\theta_0}(|W| > |w|) \approx P(|Z| > |w|) = 2\Phi(-|w|)$$

where w is the observed value of the statistic and $Z \sim N(0,1)$.

In the case of the LRT with point null hypothesis and limiting χ^2_{r-q} distribution, the (approximate) p-value is

$$\operatorname{p-value} = P_{\theta_0}(\lambda(X) > \lambda(x)) \approx P(\chi^2_{r-q} > \lambda(x))$$

Theorem: If the test statistic has a continuous distribution, then under $H_0: \theta = \theta_0$, the p-value has a Unif(0,1) distribution. Therefore, if we reject H_0 when the p-value is less than α , the probability of a Type I error is α .

Note! It is very tempting to think that $P(H_0|Data)$, but this is not the case. We have calculated the p-value assuming H_0 is true. Moreover, this kind of quantity doesn't make sense in frequentist statistics, in which we think of the parameters (determining H_0) as being fixed. However, we will see soon that this quantity does make sense (and can be calculated) in a Bayesian framework.